

# Search Notes



Application/Control No.

10/003,831

Examiner

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Applicant(s)/Patent under Reexamination

NAKANO ET AL.

Art Unit

2625

## SEARCHED

Class	Subclass	Date	Examiner
382	141 - 152	4/05	AWC
438	16		
348	87		
29	833		
438	5,14,400		
257	E23.179		
250	539.01 - 539.03		
356	237.1 - 237.6		
UPDATED	ABOVE	9/8/05	AWC

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
PG PUB TEXT SEARCH	See interference search printout	9/8/05	AWC
See interference			
search printout			

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST CLASS & TEXT SEARCH	4/05	AWC
IEEE SEARCH	04/05	AWC
INVENTOR NAME SEARCH	4/05	AWC
INTERFERENCE SEARCH HISTORY PRINTOUT	9/8/05	AWC